

Late Breaking Results: The Art of Beating the Odds with Predictor-Guided Random Design Space Exploration

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Abstract—This work introduces an innovative method for improving combinational digital circuits through random exploration in MIG-based synthesis. High-quality circuits are crucial for performance, power, and cost, making this a critical area of active research. Our approach incorporates next-state prediction and iterative selection, significantly accelerating the synthesis process. This novel method achieves up to 14× synthesis speedup and up to 20.94% better MIG minimization on the EPFL Combinational Benchmark Suite compared to state-of-the-art techniques. We further explore various predictor models and show that increased prediction accuracy does not guarantee an equivalent increase in synthesis quality of results or speedup, observing that randomness remains a desirable factor.

Index Terms—Logic & High-level Synthesis, AI and Machine Learning

I. INTRODUCTION

In recent years, substantial efforts have been made to transition the synthesis of combinational circuits from proprietary to open-source EDA tools. Still, these tools lag behind commercial alternatives in terms of area, power, timing—particularly for well-known arithmetic blocks. All-in-one tools, such as YOSYS [1], often perform minimal combinational module minimization, while more specialized software like ABC [2] and Mockturtle (MT) [3] require high expertise to configure synthesis scripts and algorithms. S.-Y. Lee et al. [4] recently introduced a random-search-based Design Space Exploration (DSE) framework for Major-Inverter-Gate (MIG) minimization, achieving remarkable improvements over the State-of-The-Art (SoTA). However, random search typically involves numerous trial-and-error iterations to find an effective algorithmic sequence. F. Faez et al. [5] have explored prediction-based synthesis and demonstrated Quality of Results (QoR) improvements and speedups, but they did not report the absolute minimal circuit size achieved. We propose a method built upon the framework of [4] that accelerates the DSE by incorporating next-state prediction and iterative selection.

II. METHOD

The original system [4] decomposes the full optimization process into a sequence of actions (steps) performed by the Mockturtle (MT) software [3]. At each step, one of thirty possible recipes, drawn from six distinct synthesis scripts with varying parameters, is randomly selected and applied to the circuit. Our method introduces three modules that collaborate to optimize the synthesis QoR. The Prediction Module (PrM) and Policy Module (PoM) optimize the sequence of recipes (see Fig. 1b) to achieve faster circuit minimization. The Inter-Iteration Selection Module (IISM) periodically restarts the synthesis from the best circuit found so far (Fig. 1a).

Recipe Selection Process: A *recipe* is an atomic action that the MT tool performs during a unitary step. The PrM predicts the resulting circuit size after applying all possible recipes to the current circuit. Based on the predictions, the PoM selects the recipe that MT should apply next. In this work, we evaluate several PrM models, including statistical and decoder-based causal auto-regressive Transformer [6]. In the PoM, the predicted metrics associated with

each recipe are passed through a SoftMax function with temperature to obtain probabilities. These probabilities are used to sample the next action, as illustrated in Fig. 1c.

Data Collection: To train the predictor models, we collect data by applying uniformly sampled recipes for a certain number of steps. At each step, we record the recipe index along with the resulting size-related metrics (LUT6, transistor, and MIG node counts, etc.).

Inter-Iteration Selection Process: After a fixed number of steps, the IISM selects the best circuit. All chains are restarted from the selected design, initiating a new iteration. Parallel chains start from the same circuit and proceed with an individual sequence of recipes.

III. EXPERIMENTS

In a first step, we choose to optimize the ALU control unit (`control.v`) from the EPFL Benchmark [7], as its small size allowed for fast iteration. In this section, the target metric used is the number of transistors, as reported by YOSYS [1] after a technology independent `abc` step. Data collection is done with 500 runs, each with a single chain of 5000 steps. Unless otherwise stated, for all data points of each experiment presented below, we perform 200 runs, each with 1000 steps across iterations and chains. The real compute time can differ, as the PrM and recipe execution durations can vary. A single MT script takes 0.065 s on average (0.27 s including metrics extraction) on a 32-core 2.8 GHz x86_64 server CPU.

Prediction Accuracy: We investigate several prediction models: 1) The statistical model predicts transistor variations based on the mean change observed for each recipe in the training set; 2) Other models incorporate metrics derived from previous circuits, with context lengths ranging up to 20 past states for the transformer-based model. Table I summarizes the Root Mean Square Error (RMSE) achieved on a validation set by different models across various configurations (lower is better). We note that higher prediction accuracy does not necessarily lead to higher QoR.

TABLE I: RMSE of the PrM, speedup and minimum size achieved.

| Configuration | RMSE | Speedup@365 | Min. Trans. |
|-------------------------|-------------|-------------|-------------|
| Uniform (Baseline) | - | 1.00 | 354 |
| Statistical, 1SA | 19.4 | 5.48 | 344 |
| MLP, 1SA | 17.5 | 5.71 | 348 |
| Statistical, 2SA | 23.6 | 9.60 | 346 |
| Transformer, 2SA | 18.0 | 9.00 | 340 |
| Statistical, 1SA + IISM | 19.2 | 10.60 | 340 |

Temperature Effect: Higher SoftMax temperature results in a more uniform distribution during sampling, whereas lower temperatures favor the predicted top-performing recipes. To investigate the impact of the parameter on the QoR we perform a sweep (see Fig. 2a). We see that there is an optimum around $T = 5$, where significantly better results can be achieved compared to the uniform distribution (baseline). This suggests selecting top-performing recipes improves QoR, but keeping some degree of randomness is essential.

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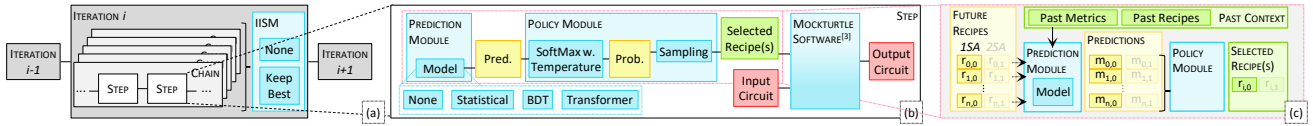


Fig. 1: Overview of the proposed prediction-based DSE framework. (a) Multiple parallel chains and IISM. (b) Unitary steps with recipe selection and MT recipe processing. (c) Detailed view of recipe performance prediction and recipe selection by the PrM and PoM.

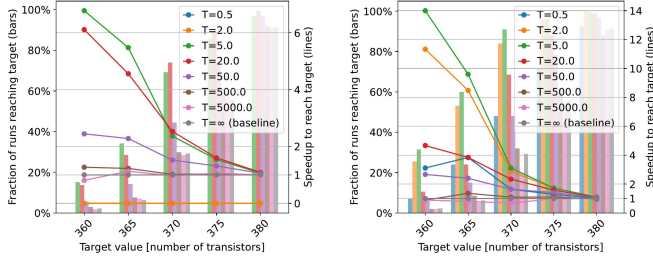


Fig. 2: Effect of the temperature on the speedup factor for various target values for ctrl.v. Statistical model. a) 1SA, b) 2SA.

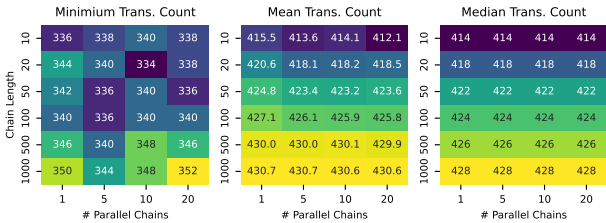


Fig. 3: Effect of chain length and number of parallel chains on achieved minimum, mean and median transistor counts.

Speedup: We define synthesis speed as the average number of runs required to reach a target QoR. Speedup is the ratio of a method’s speed to the baseline speed. Fig. 2a shows that by using the statistical model, equivalent QoR is achieved in fewer runs on average. This speedup is more pronounced for lower target values (higher QoR). Table I shows the speedup reached at a target transistor count of 365. Furthermore, without IISM, circuits with the lowest transistor count could only be obtained with the prediction model approach.

Two-Step Ahead Predictions (2SA): We further extend our method to 2SA predictions, where the PrM and PoM select the *pair* of recipes for the two next steps. Table I and Fig. 2 show that 2SA achieves drastically better speedups than 1SA. For a target transistor count of 360, 2SA prediction reaches up to 14× speedup.

IISM Effect: We compare 1SA prediction with and without IISM in Table I. With chain length 50 and 1 parallel chain, we observe the speedup increases from 5.48 to 10.60. We also perform a grid search over the number of parallel chains and chain length with uniform sampling (see Fig. 3). For this experiment, we keep the total number of steps per configuration constant by varying the number of runs. We find that an increase in parallel chains is beneficial, which has been verified for different benchmark designs. However, the optimal chain length varies widely across designs. Also, while a configuration maximizing the QoR across many steps usually achieves high-quality, it does not always yield the absolute optimum (338 transistors count vs. absolute minimum of 334 in Fig. 3).

IV. RESULTS

In the following, we deploy the EPFL Combinational Benchmark [7]. Starting with the original Verilog implementation, we apply our method targeting MIG nodes minimization, and Table II presents the resulting minimal circuit. We demonstrate an improvement of 20.94%

in MIG minimization on the max.v circuit. As the duration of each step grows dramatically with the design size (from 5 ms to 21 min for some recipes), we have not yet applied the full method on larger designs. And-Inverter Graph (AIG) node counts of the MIG optimized circuits are added for reference, but have not been optimized for. The synthesized designs are available on GitHub (link).

TABLE II: Best QoR achieved on the EPFL Benchmark [7]

| Bench. | MIG Nodes | | Depth | AIG Nodes | |
|------------|-----------|---------------|-------------|-----------|--------|
| | [8] | [4] | | Ours | [9] |
| adder | 384 | 384 | 384 | 129 | 384 |
| bar | 2433 | 1906 | 1800 | 15 | 2696 |
| div | 12462 | 12368 | 12434 | 2316 | 19250 |
| hyp | 115541 | 115539 | 131487 | 8991 | 209460 |
| log2 | 22010 | 22008 | 23291 | 217 | 30522 |
| max | 2190 | 1939 | 1533 | 260 | 2676 |
| multiplier | 17112 | 17112 | 18515 | 141 | 25371 |
| sin | 3870 | 3869 | 3842 | 118 | 4987 |
| sqrt | 12357 | 12247 | 19430 | 5722 | 19706 |
| square | 8138 | 8089 | 8132 | 128 | 17010 |
| arbiter | 6711 | 792 | 685 | 36 | 879 |
| cavlc | 492 | 374 | 329 | 15 | 483 |
| ctrl | 74 | 60 | 58 | 9 | 71 |
| dec | 304 | 304 | 304 | 3 | 304 |
| i2c | 871 | 636 | 618 | 21 | 710 |
| int2float | 172 | 115 | 107 | 14 | 145 |
| mem_ctrl | 32097 | 6886 | 6250 | 36 | 7644 |
| priority | 406 | 337 | 315 | 14 | 375 |
| router | 147 | 97 | 92 | 14 | 96 |
| voter | 4555 | 3894 | 3849 | 41 | 9817 |

V. CONCLUSION

The proposed method shows a 14× synthesis speedup and 20.94% better MIG minimization through the integration of predictive models and iterative selection strategies. Hyperparameter optimization remains crucial, as the best configuration varies among circuits. Since a considerable number of steps are required to achieve the best QoR, minimization of large designs remains challenging. We believe that further QoR improvement can be achieved with reinforcement learning methods. As the PrM, PoM, and IISM are originally independent of the MT software, our method could be deployed with other tools.

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